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| Notice of References Cited | Application/Control No. 10/033,846 | Applicant(s)/Patent Under Reexamination NISHIMURA, TETSUYA | |
| | Examiner Eric Wong | Art Unit 2874 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| | A | US-4,772,123 | 09-1988 | Radner, Raymond J. | 356/153 |
| | B | US-5,383,118 | 01-1995 | Nguyen, Hung N. | 700/59 |
| | C | US- | | | |
| | D | US- | | | |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|--------------|----------------|
| | N | JP 04221912 A | 08-1992 | Japan | ITO et al. | G02B 06/42 |
| | O | JP 09159882 A | 06-1997 | Japan | AMASE et al. | G02B 06/42 |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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